

**Notice of References Cited**Application/Control No.  
10/775,824Applicant(s)/Patent Under  
Reexamination  
LEUNG ET AL.Examiner  
Le NguyenArt Unit  
2174

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,442,512	08-2002	Sengupta et al.	703/6
*	B	US-5,966,126	10-1999	Szabo, Andrew J.	715/762
*	C	US-5,666,503	09-1997	Campanelli et al.	715/853
*	D	US-2003/0184580	10-2003	Kodosky et al.	345/734
*	E	US-6,425,121	07-2002	Phillips, Christopher J.	717/109
*	F	US-5,555,357	09-1996	Fernandes et al.	345/441
*	G	US-6,486,899	11-2002	Bush, Jr., John Robbins	715/855
*	H	US-6,121,965	09-2000	Kenney et al.	715/810
*	I	US-5,986,669	11-1999	Kirkland, Dale	345/620
*	J	US-5,831,632	11-1998	Schuster et al.	345/441
*	K	US-5,675,753	10-1997	Hansen et al.	715/744
*	L	US-5,745,122	04-1998	Gay et al.	345/619
*	M	US-5,231,695	07-1993	Harrington, Steven J.	345/621

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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